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<i>Substitute for Form 1449A/PTO</i>		Application #	10/549,808
INFORMATION DISCLOSURE STATEMENT BY APPLICANT		Confirmation #	7965
		Filing Date	September 19, 2005
		First Inventor	PHILIPPOU
		Art Unit	1745
		Examiner	
Sheet 1 of 1		Docket #	P08753US00/MP

U.S. PATENT DOCUMENTS				
Exam. Initial*	Document No. Number - Kind	Publ. Date MM-DD-YYYY	Name Patentee or Applicant	Relevance Passages/Figs.
	US-2004/0246334	12-09-2004	Philippou (U.S. Equivalent of WO 2003/019299)	
	US-2004/0037959	02-26-2004	Mirkin et al. (U.S. Equivalent of WO 2001/091855)	
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FOREIGN PATENT DOCUMENTS					
Exam. Initial*	Country-Number-Kind	Publ. Date MM-DD-YYYY	Name Patentee or Applicant	Relevance Passages/Figs.	Trans- lation

NON PATENT LITERATURE DOCUMENTS					
Exam. Initial*	Include NAME of the author (in CAPS), Title of Article/Item, Date, Page(s), Volume-Issue No., Publisher, City and/or Country where published				Trans- lation
	EIGLER et al., 'Positioning single atoms with a scanning tunneling microscope', Nature, 5 April 1990, Volume 344, Pages 524-526. Entire article				
	SITTI, 7 October 1998, [online], [retrieved on 22 June 2004]. Retrieved from the internet: URL: http://dfs.iis.u-tokyo.ac.jp/~shintani/Nano/research.html Entire article				
	BOWEN et al., 'Experimental investigation of continuous variable quantum teleportation', Phys Rev A, 10 March 2003, Volume 67. Entire article				
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	STERNBACH et al., StarTrek The Next Generation Technical Manual, New York, Pocket Books, 1991. ISBN 0-671-70427-3, pages 90, 91 & 102-109.				
	HATAMURA et al. 'Direct Coupling System between Nanometer World and Human World' in: Proceedings of the IEEE Workshop on Micro Electro Mechanical Systems, New York, IEEE, 1990, pages 203-208.				

Examiner Signature	/Jeff Aftergut/	Date Considered	09/29/2009
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* Examiner: Initial if considered, whether or not citation is in conformance with MPEP §609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.